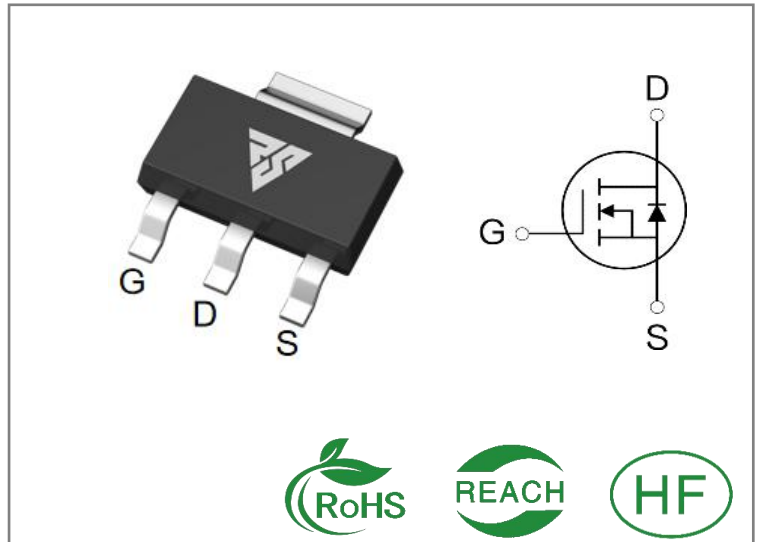


ID	R <sub>DS(ON)</sub> (Typ)	VDSS
2A	3.5Ω	600V


**Applications:**

- Switch Mode Power Supply(SMPS)
- Uninterruptible Power Supply (UPS)
- Power Factor Correction (PFC)

**Features:**

- Fast switching speed
- 100% avalanche tested
- Improved dv/dt capability

**Ordering Information**

Part Number	Package	Marking	Packing	Qty.
RS2N60C	SOT-223	RS2N60C	Tape&reel	4000 PCS

**Absolute Maximum Ratings** Tc= 25°C unless otherwise specified

Symbol	Parameter	RS2N60C	Units
VDSS	Drain-to-Source Voltage	600	V
ID	Continuous Drain Current	2	A
IDM	Pulsed Drain Current (Note*1)	8	
PD	Power Dissipation	28	W
VGS	Gate- to- Source Voltage	±30	V
EAS	Single Pulse Avalanche Energy L = 10.0mH, VDD = 50V, RG = 25 Ω	28.8	mJ
IAS	Avalanche Current (Note*1)	2.4	A
E <sub>AR</sub>	Repetitive Avalanche Energy (Note*1)	0.12	mJ
TL TPKG	Maximum Temperature for Soldering	300	°C
	Leads at 0.063in(1.6mm)from Case for 10 seconds Package Body for 10 seconds	260	
TJ and TSTG	Operating Junction and Storage Temperature Range	-55 to 150	

\* Drain Current Limited by Maximum Junction Temperature

Caution: Stresses greater than those listed in the " Absolute Maximum Ratings" Table may cause permanent damage to the device.

**Thermal Resistance**

Symbol	Parameter	RS2N60C	Units	Test Conditions
R $\theta$ JC	Junction-to-Case	4.53	$^{\circ}\text{C} / \text{W}$	Drain lead soldered to water cooled heatsink, PD adjusted for a peak junction temperature of + 1 5 0 $^{\circ}\text{C}$
R $\theta$ JA	Junction-to-Ambient	60		1 cubic foot chamber, free air.

**OFF Characteristics** T<sub>J</sub>= 25 $^{\circ}\text{C}$  unless otherwise specified

Symbol	Parameter	Min.	Typ.	Max.	Units	Test Conditions
BVDSS	Drain- to- source Breakdown Voltage	600	--	--	V	V <sub>GS</sub> =0V, I <sub>D</sub> =250 $\mu\text{A}$
IDSS	Drain- to- Source Leakage Current	--	--	1	$\mu\text{A}$	V <sub>D</sub> S=600V, V <sub>G</sub> S=0 V
IGSS	Gate- to- Source Forward Leakage	--	--	100	nA	V <sub>G</sub> S=30V , V <sub>D</sub> S=0V
	Gate- to- Source Reverse Leakage	--	--	-100		V <sub>G</sub> S=-30V , V <sub>D</sub> S=0 V

**ON Characteristics** T<sub>J</sub>=25 $^{\circ}\text{C}$  unless otherwise specified

Symbol	Parameter	Min.	Typ.	Max.	Units	Test Conditions
R <sub>DS(on)</sub>	Static Drain- to- Source On-Resistance(Note*2)	--	3.5	4.2	$\Omega$	V <sub>G</sub> S=10V, I <sub>D</sub> =1A
V <sub>GS(TH)</sub>	Gate Threshold Voltage	3	--	4	V	V <sub>G</sub> S=V <sub>D</sub> S, I <sub>D</sub> =250 $\mu\text{A}$

**Resistive Switching Characteristics** Essentially independent of operating temperature

Symbol	Parameter	Min.	Typ.	Max.	Units	Test Conditions
t <sub>d(ON)</sub>	Turn- on Delay Time	--	33.6	--	nS	V <sub>D</sub> S=300V ID=2A R <sub>G</sub> =25 $\Omega$
t <sub>rise</sub>	Rise Time	--	7.2	--		
t <sub>d(OFF)</sub>	Turn- OFF Delay Time	--	64	--		
t <sub>fall</sub>	Fall Time	--	31.2	--		

**Dynamic Characteristics** Essentially independent of operating temperature

Symbol	Parameter	Min.	Typ.	Max.	Units	Test Conditions
Ciss	Input Capacitance	--	248.5	--	pF	VGS=0V VDS=25V f=1.0MHz
Coss	Output Capacitance	--	30	--		
Crss	Reverse Transfer Capacitance	--	4.2	--		
Qg	Total Gate Charge	--	11	--	nC	VDS=480V ID=2A VGS=10V
Qgs	Gate- to- Source Charge	--	1.55	--		
Qgd	Gate-to-Drain(" Miller") Charge	--	6.15	--		

**Source- Drain Diode Characteristics**

Symbol	Parameter	Min.	Typ.	Max.	Units	Test Conditions
IS	Continuous Source Current	--	--	2	A	Integral pn- diode in MOSFET
ISM	Maximum Pulsed Current	--	--	8	A	
VSD	Diode Forward Voltage	--	--	1.4	V	IS=1A,VGS=0V
trr	Reverse Recovery Time	--	490	--	nS	VGS=0V IS=2A,di/dt=100A/ μs
Qrr	Reverse Recovery Charge	--	0.6	--	μC	

**Notes:**

- \* 1. Repetitive rating, pulse width limited by maximum junction temperature.
- \* 2. Pulse Test: Pulse width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 1\%$

Typical Feature Curve

Figure 1. Output Characteristics ( $T_J = 25^\circ\text{C}$ )

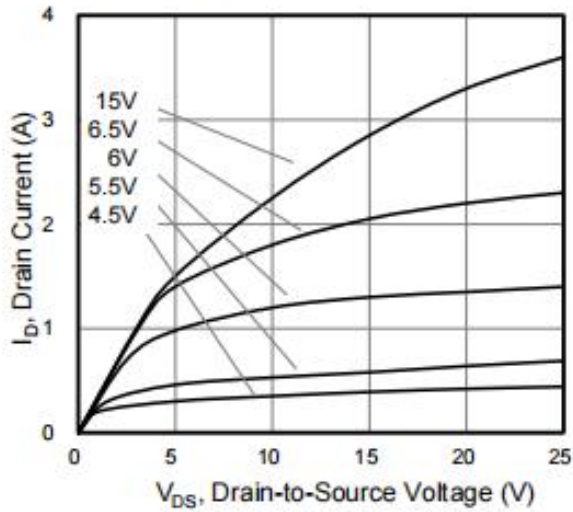


Figure 2. Body Diode Forward Voltage

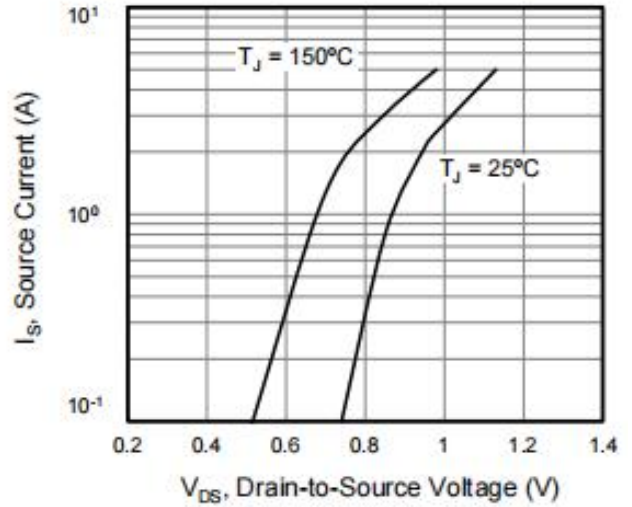


Figure 3. Drain Current vs. Temperature

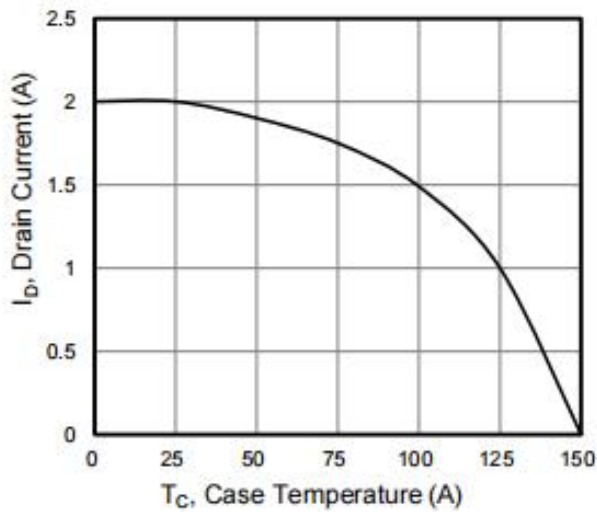


Figure 4.  $BV_{DSS}$  Variation vs. Temperature

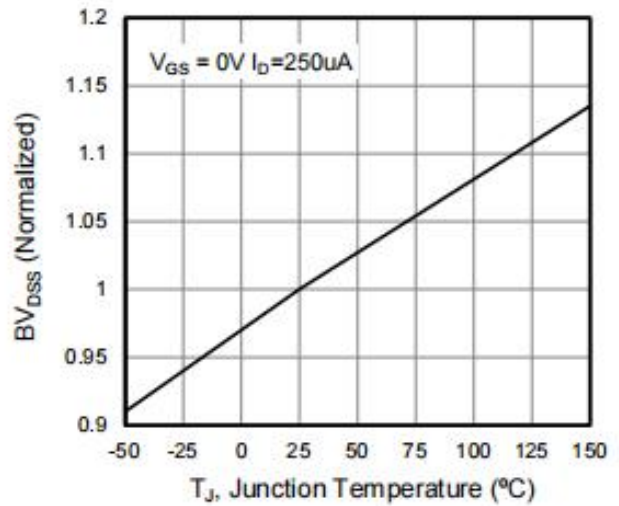


Figure 5. Transfer Characteristics

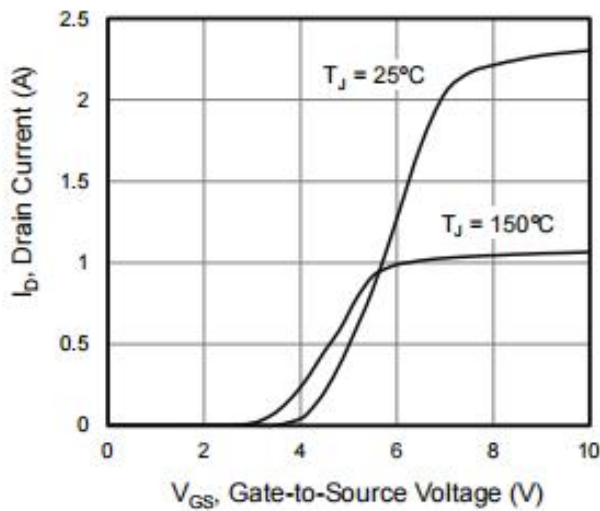


Figure 6. On-Resistance vs. Temperature

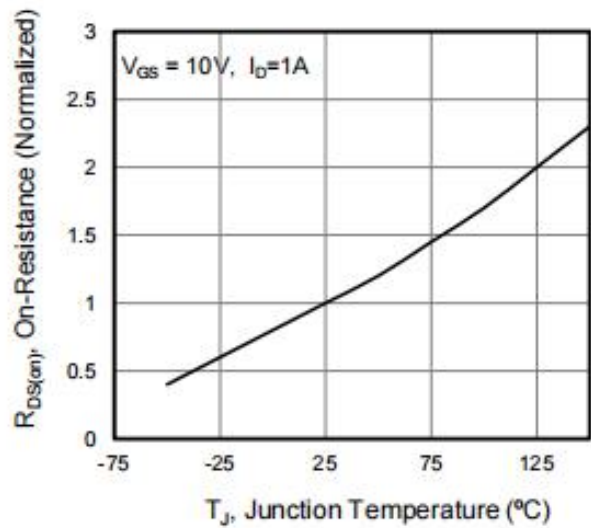


Figure 7. Capacitance

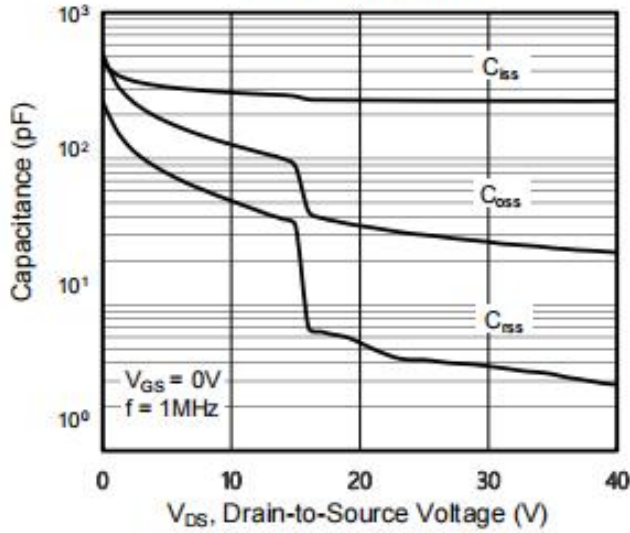


Figure 8. Gate Charge

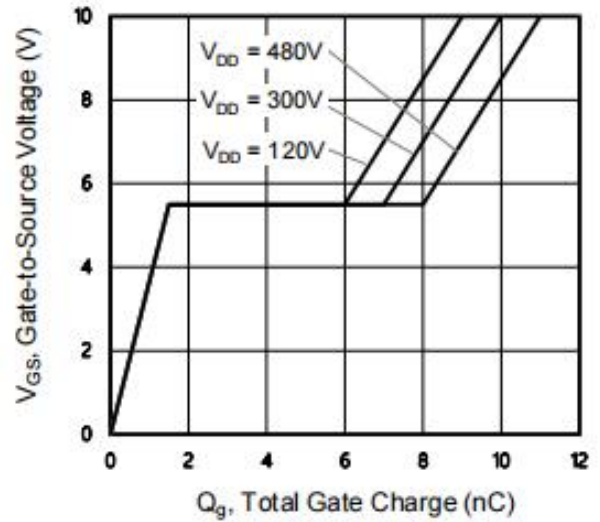
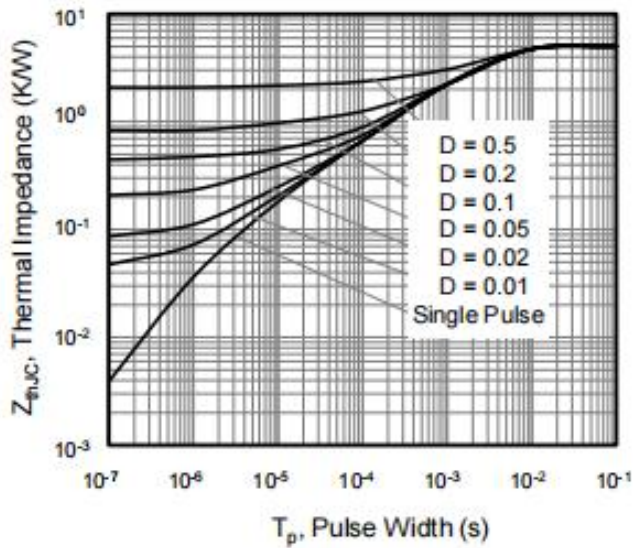
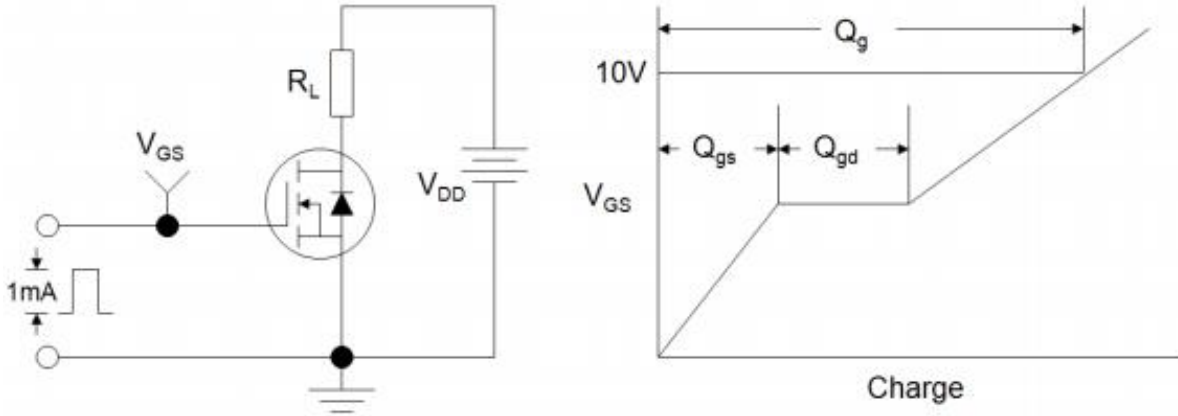


Figure 9. Transient Thermal Impedance

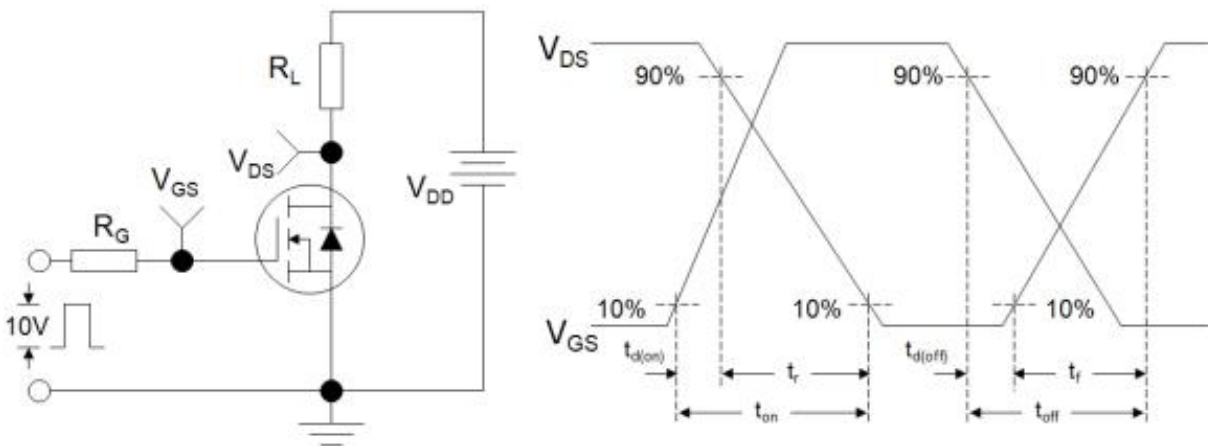


**Test Circuits and Waveforms**

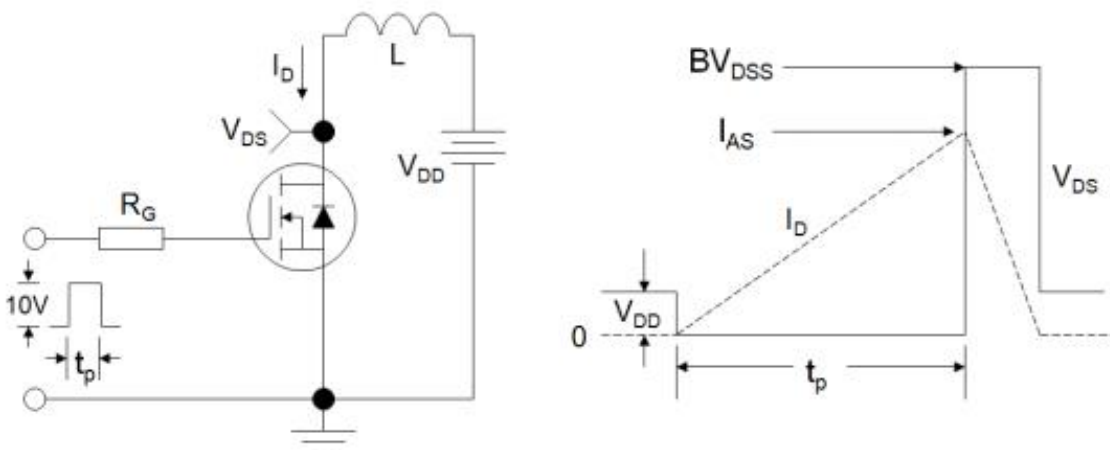
**Figure A: Gate Charge Test Circuit and Waveform**



**Figure B: Resistive Switching Test Circuit and Waveform**

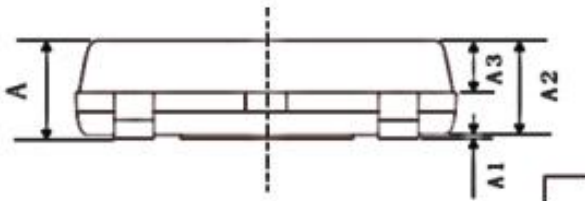
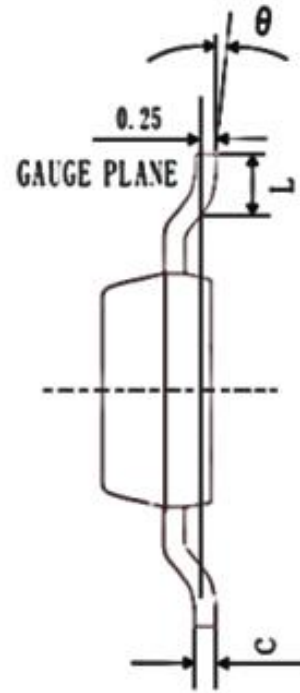
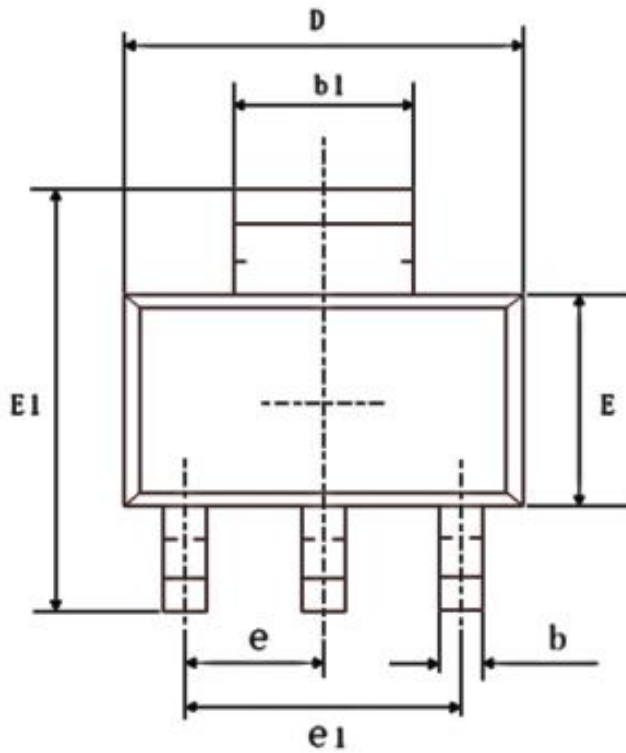


**Figure C: Unclamped Inductive Switching Test Circuit and Waveform**



Package outline drawing

SOT-223



SYMBOLS	MILLIMETERS	
	MIN	MAX
A	--	1.80
A1	0.00	0.10
A2	1.50	1.70
A3	0.85	0.95
b	0.66	0.80
b1	2.96	3.10
C	0.25	0.35
D	6.30	6.70
E	3.30	3.70
E1	6.80	7.20
e1	4.40	4.80
L	0.90	1.15
e	0.00	10.00
e	2.3BSC	

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